Randomization for Safer, more Reliable and Secure, High-Performance Automotive Processors

URL: https://ieeexplore.ieee.org/document/8756263

Authors: Trilla, David / Hernandez, Carles / Abella, Jaume / Cazorla, Francisco

Publication: IEEE Design & Test

Pagination:

Barcelona Supercomputing Center - Centro Nacional de Supercomputación